

Search Notes

Application/Control No.

10/635,689

Examiner

Lan Nguyen

Applicant(s)/Patent under
Reexamination

YASUMOTO ET AL.

Art Unit

3683

SEARCHED

Class	Subclass	Date	Examiner
188	378- 380	8/11/06	XLN
267	140.12		
	292		
	293		
74	492		
	552		
280	728.2		
	731		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
TEXT Search included	8/11/06	XLN
JP Translation Request JP-2824382		
JP-02057475 JP-4-46246		